

<b>Notice of References Cited</b>	Application/Control No. 1	Applicant(s)/Patent Under Reexamination DUNNOUS ET AL.	
	Examiner David Turocy	Art Unit 1762	Page 1 of 1

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*	B	US-2003/0232913	12-2003	Bakule, Ronald David	524/500
*	C	US-2002/0013401	01-2002	Friel et al.	524/501
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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